

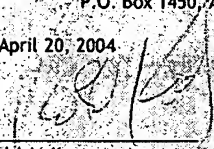


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On: April 20, 2004


Ronald A. Koatz
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REGISTRATION NO. 31,774

April 20, 2004
DATE OF SIGNATURE

PATENT

03-0078-UNI

C7695(V)

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Customer No.: 000201
Applicant: Smit-Kingma et al.
Serial No.: 10/734,026
Filed: December 11, 2003
For: IDENTIFICATION METHOD

Group:
Examiner:
Edgewater, NJ 07020
April 20, 2004

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, Virginia 22313-1450

Sir:

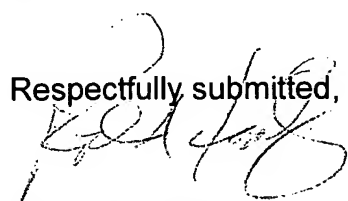
Documents relating to the above-referenced application are submitted herewith. The following information is intended for the Examiner's information and for citation with the instant case. This submission does not constitute either a representation that a thorough search has been made or an admission that the documents cited herein are properly citable against the above-captioned application. Any comments which may accompany the documents are believed to constitute a fair representation of the pertinence of said documents. However, these comments are not intended to take the

place of the Examiner's independent consideration of each document. An attached PTO Form 1449 lists these documents.

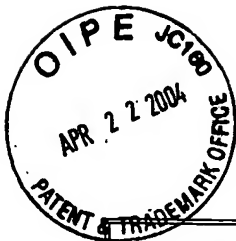
European Search Report Application No. EP 02 08 0330 dated April 4, 2003;
WO 01/46509 A1 to Sams et al. (6/01) assigned to Bsh Bosch Siemens
Hausgeraete (English language Abstract on face page);
Bickel A.: "Nir Analyzers Earn Their Place in Process Control", I & CS – Industrial
and Process Control Magazine, Chilton Company, Radnor, PA, US, Vol. 62, No. 7
(7/89) pages 45-48, XP000072786);
U.S. Patent Application Publication No. 2001/0042391 A1 to Wobkemeier
(11/01);
U.S. Patent Application Publication No. 2001/0049846 A1 to Guzzi et al. (12/01)
assigned to The Procter & Gamble Co.;
DE 199 20 592 A to Thiemer (11/00) assigned to Cetex Chemnitzer
Textilmaschinen (English language Abstract attached);
EP 0 612 996 A2 to Pike (8/94) assigned to Black & Decker Inc.;
U.S. Patent Application Publication No. 2002/0113212 A1 to Meglen et al. (8/02).

No additional fee is required since this information is filed prior to the first Office Action on the merits. However if any such is required, please deduct from Deposit Account No. 12-1155.

Respectfully submitted,


Ronald A. Koatz
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RAK:sc
201-840-2912



PTO-1449

U.S. Dept. of Commerce - Patent & Trademark Office

INFORMATION DISCLOSURE STATEMENT BY APPLICANT**LIST OF REFERENCES CITED BY APPLICANT**

Applicant: Smit-Kingma et al.
Serial No.: 10/734,026
Filing Date: December 11, 2003

Attorney Docket No.: C7695(V)
UNUS No.: 03-0078-UNI
Group: 2877

U.S. PATENT DOCUMENTS

EXAM. INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	2001/0042391 A1	11/01	Wobkemeier			
	2001/0049846 A1	12/01	Guzzi et al.			
	2002/0113212 A1	8/02	Meglen et al.			

FOREIGN PATENT DOCUMENTS

EXAM. INITIAL	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB-CLASS	TRANSLATION YES NO
	01/46509 A1	6/01	WO			
	199 20 592 A	11/00	DE			
	0 612 996 A2	8/94	EP			

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

	European Search Report Application No. EP 02 08 0330 dated April 4, 2003
	Bickel A.: "Nir Analyzers Earn Their Place in Process Control", I & CS – Industrial and Process Control Magazine, Chilton Company, Radnor, PA, US, Vol. 62, No. 7 (7/89) pages 45-48, XP000072786)
Examiner:	Date Considered:

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.